

Resource Summary Report

Generated by [RRID](#) on Aug 5, 2026

JEOL: JSM-IT500HR InTouchScope Scanning Electron Microscope (SEM)

RRID:SCR_020189

Type: Tool

Proper Citation

JEOL: JSM-IT500HR InTouchScope Scanning Electron Microscope (SEM)
(RRID:SCR_020189)

Resource Information

URL: <https://www.jeolusa.com/PRODUCTS/Scanning-Electron-Microscopes-SEM/High-Res-Large-Chamber-SEM/JSM-IT500HR>

Proper Citation: JEOL: JSM-IT500HR InTouchScope Scanning Electron Microscope (SEM) (RRID:SCR_020189)

Description: Scanning Electron Microscope that provides high resolution imaging along with high sensitivity and high spatial resolution analysis

Resource Type: instrument resource

Keywords: Jeol, JEOL, Scanning Electron Microscope, Instrument Equipment, USEDit,

Availability: Commercially available

Resource Name: JEOL: JSM-IT500HR InTouchScope Scanning Electron Microscope (SEM)

Resource ID: SCR_020189

Alternate IDs: Model_Number_JSM-IT500HR InTouchScope

Record Creation Time: 20220129T080349+0000

Record Last Update: 20260801T190645+0000

Ratings and Alerts

No rating or validation information has been found for JEOL: JSM-IT500HR InTouchScope Scanning Electron Microscope (SEM).

No alerts have been found for JEOL: JSM-IT500HR InTouchScope Scanning Electron Microscope (SEM).

Data and Source Information

Source: [SciCrunch Registry](#)

Usage and Citation Metrics

We have not found any literature mentions for this resource.